

Notice of References Cited	Application/Control No. 10/582,490		Applicant(s)/Patent Under Reexamination WALLMARK ET AL.	
	Examiner HAI V. NGUYEN		Art Unit 2618	Page 1 of 4

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,229,817 A	10-1980	Morgan et al.	380/52
*	B	US-5,048,085 A	09-1991	Abraham et al.	713/159
*	C	US-5,148,481 A	09-1992	Abraham et al.	380/46
*	D	US-5,301,231 A	04-1994	Abraham et al.	713/191
*	E	US-5,926,546 A	07-1999	Maeda et al.	705/65
*	F	US-5,960,084 A	09-1999	Angelo, Michael F.	713/185
*	G	US-6,035,380 A	03-2000	Shelton et al.	711/163
*	H	US-6,169,802 B1	01-2001	Lerner et al.	380/44
*	I	US-6,198,382 B1	03-2001	Berger et al.	340/10.34
*	J	US-2002/0034302 A1	03-2002	Moriai et al.	380/270
*	K	US-2002/0095594 A1	07-2002	Dellmo et al.	713/200
*	L	US-2002/0120843 A1	08-2002	Goodman et al.	713/164
*	M	US-2002/0104004 A1	08-2002	Couillard, Bruno	713/178

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	I					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited	Application/Control No. 10/582,490		Applicant(s)/Patent Under Reexamination WALLMARK ET AL.	
	Examiner HAI V. NGUYEN		Art Unit 2618	Page 2 of 4

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0114467 A1	08-2002	Vatanen, Harri	380/270
*	B	US-2002/0188863 A1	12-2002	Friedman, Solomon	713/201
*	C	US-2003/0026427 A1	02-2003	Couillard, Bruno	380/277
*	D	US-2003/0093698 A1	05-2003	Challener et al.	713/202
*	E	US-2003/0132918 A1	07-2003	Fitch et al.	345/173
*	F	US-6,592,031 B1	07-2003	Klatt, Dieter	235/382
*	G	US-2003/0128843 A1	07-2003	Brown et al.	380/46
*	H	US-6,662,163 B1	12-2003	Albayrak et al.	704/275
*	I	US-6,697,944 B1	02-2004	Jones et al.	713/168
*	J	US-2004/0082361 A1	04-2004	Rajagopalan, Bala	455/556.1
*	K	US-6,748,535 B1	06-2004	Ryan et al.	713/189
*	L	US-2004/0125758 A1	07-2004	Hayduk, Matthew A.	370/310
*	M	US-2004/0228175 A1	11-2004	Candelore et al.	365/158

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited	Application/Control No. 10/582,490		Applicant(s)/Patent Under Reexamination WALLMARK ET AL.	
	Examiner HAI V. NGUYEN		Art Unit 2618	Page 3 of 4

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0036622 A1	02-2005	Hay et al.	380/270
*	B	US-2005/0094463 A1	05-2005	Nishizawa et al.	365/222
*	C	US-6,957,342 B2	10-2005	Vatanen, Harri	713/192
*	D	US-6,971,021 B1	11-2005	Daspit et al.	713/192
*	E	US-2005/0286718 A1	12-2005	Meintrup et al.	380/046
*	F	US-7,082,539 B1	07-2006	Kitahara et al.	713/189
*	G	US-7,146,179 B2	12-2006	Parulski et al.	455/456.3
*	H	US-7,178,028 B2	02-2007	Go et al.	713/170
*	I	US-2007/0067835 A1	03-2007	Koistinen et al.	726/009
*	J	US-2007/0074045 A1	03-2007	Van Essen et al.	713/189
*	K	US-7,203,842 B2	04-2007	Kean, Thomas A.	713/189
*	L	US-2007/0098153 A1	05-2007	NISHIKAWA, Shigeru	380/030
*	M	US-7,325,746 B2	02-2008	Nishizawa et al.	235/492

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited	Application/Control No. 10/582,490		Applicant(s)/Patent Under Reexamination WALLMARK ET AL.	
	Examiner HAI V. NGUYEN		Art Unit 2618	Page 4 of 4

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,366,913 B1	04-2008	Haley, Jeffrey T.	713/189
*	B	US-7,398,544 B2	07-2008	Candelore et al.	726/2
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.